



NPN Epitaxial Planar Silicon Transistor **2SC3689**— High-hFE, Low-Frequency **General-Purpose Amplifier Applications**

Applications

· Low-frequency general-purpose amplifiers, drivers, muting circuit.

Features

- Small Cob (Cob=1.5pF).
- · Ultrasmall-sized package permitting 2SC3689-used sets to be made smaller, slimmer.
- · Adoption of MBIT process.
- High DC current gain (hFE=800 to 3200).
- Low collector-to-emitter saturation voltage (VCE(sat)≤0.5V).
- High VEBO (VEBO \geq 15V).

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	VCBO		60	V
Collector-to-Emitter Voltage	VCEO		50	V
Emitter-to-Base Voltage	VEBO		15	V
Collector Current	IC		100	mA
Collector Current (Pulse)	ICP		200	mA
Collector Dissipation	PC		200	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

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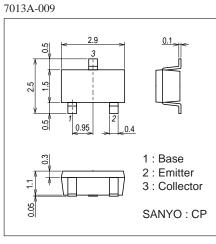
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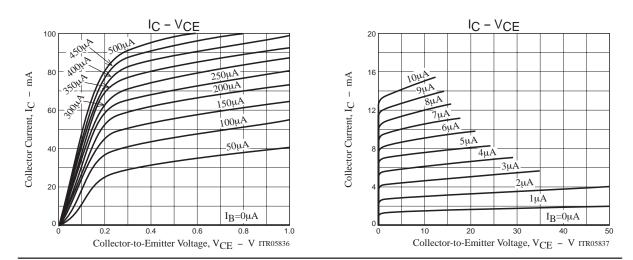
Electrical Characteristics at Ta=25°C

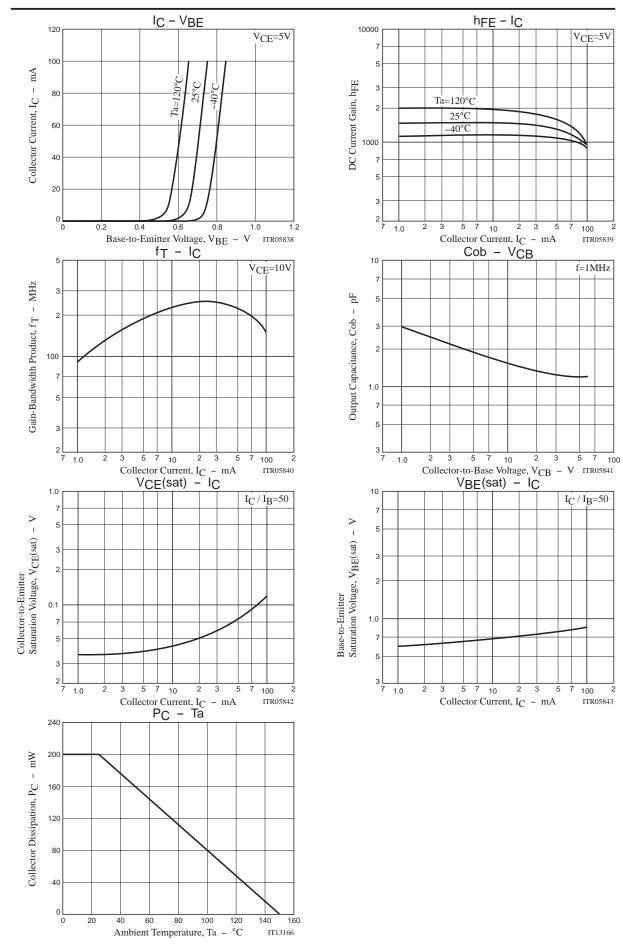
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Unit
Collector Cutoff Current	ICBO	V _{CB} =40V, I _E =0A			0.1	μΑ
Emitter Cutoff Current	IEBO	V _{EB} =10V, I _C =0A			0.1	μΑ
DC Current Gain	hFE	V _{CE} =5V, I _C =10mA	800	1500	3200	
Gain-Bandwidth Product	fT	V _{CE} =10V, I _C =10mA		200		MHz
Output Capacitance	Cob	V _{CB} =10V, f=1MHz		1.5		pF
Collector-to-Emitter Saturation Voltage	VCE(sat)	IC=50mA, IB=1mA		0.1	0.5	V
Base-to-Emitter Saturation Voltage	V _{BE} (sat)	IC=50mA, IB=1mA		0.8	1.1	V
Collector-to-Base Breakdown Voltage	V(BR)CBO	IC=10μA, IE=0A	60			V
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	IC=1mA, RBE=∞	50			V
Emitter-to-Base Breakdown Voltage	V(BR)EBO	I _E =10μA, I _C =0A	15			V

Package Dimensions

unit : mm (typ)







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